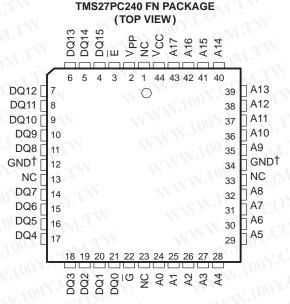
TMS27C240 262144 BY 16-BIT UV ERASABLE TMS27PC240 262144 BY 16-BIT PROGRAMMABLE READ-ONLY MEMORIES

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- Organization . . . 262144 by 16 Bits
- Single 5-V Power Supply
- All Inputs/Outputs Fully TTL Compatible
- Static Operations (No Clocks, No Refresh)
- Max Access/Min Cycle Time

V_{CC} ± 10% '27C/PC240-10 100 ns '27C/PC240-12 120 ns '27C/PC240-15 150 ns

- 16-Bit Output For Use in Microprocessor-Based Systems
- Very High Speed SNAP! Pulse Programming
- Power-Saving CMOS Technology
- 3-State Output Buffers
- 400-mV Minimum DC Noise Immunity With Standard TTL Loads
- Latchup Immunity of 250 mA on All Input and Output Lines
- No Pullup Resistors Required
- Low Power Dissipation (V_{CC} = 5.5 V)
 - Active ... 275 mW Worst Case
 - Standby . . . 0.55 mW Worst Case (CMOS-Input Levels)
- Temperature Range Options



PIN	NOMENCLATURE
A0-A17	Address Inputs
DQ0-DQ15	Inputs (programming)/Outputs
<u>E</u>	Chip Enable
G	Output Enable
GND	Ground
NC	No Connection
Vcc	5-V Supply
VPP	13-V Power Supply [‡]

[†] Pins 11 and 30 (J package) and pins 12 and 34 (FN package) must be connected externally to ground.

description

The TMS27C240 series are 262144 by 16-bit (4194304-bit), ultraviolet-light erasable, electrically programmable read-only memories (EPROMs).

The TMS27PC240 series are 262144 by 16-bit (4194304-bit), one-time programmable (OTP) electrically programmable read-only memories (PROMs).

These devices are fabricated using power-saving CMOS technology for high speed and simple interface with MOS and bipolar circuits. All inputs (including program data inputs) can be driven by Series 74 TTL circuits without the use of external pull-up resistors. Each output can drive one Series 74 TTL circuit without external resistors.

The TMS27C240 EPROM is offered in a dual-in-line ceramic package (J suffix) designed for insertion in mounting hole rows on 15,2-mm (600-mil) centers. The TMS27C240 is offered with two choices of temperature ranges of 0°C to 70°C (JL suffix) and – 40°C to 85°C (JE suffix). See Table 1.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.



[‡]Only in program mode

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TMS27C240 J PACKAGE (TOP VIEW)

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V <u>PP</u> [1		h ACC.	
	2	39] A17	
DQ15	3	38	A16	
DQ14		37	A15	
DQ13[36] A14	
DQ12		35]A13	
DQ11[7	34	LA1Z	
DQ10	8	33]A11	
DQ9	9	32	A10	
DQ8 SND†	10	31	A9	
√ GND†[11 N	30	GNDT	
DQ7		29	A8	
DQ6	13	28	A7	
DQ5		27	[] A6	
DQ4		26	A5	
DQ3		25	A 4	
DQ2	17	24	ПАЗ	
DQ1	18] A2	
DQ0	19	22	A1	
G	20	21	A0	
	20	21	P. WAY.	

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description (continued)

The TMS27PC240 OTP PROM is offered in a 44-lead plastic leaded chip carrier package using 1,25-mm (50-mil) lead spacing (FN suffix). The TMS27PC240 is offered with two choices of temperature ranges of 0°C to 70°C (FNL suffix) and -40°C to 85°C (FNE suffix). See Table 1.

Table 1. Temperature Range Suffixes

TW VI	SUFFIX FOR OPERATING FRE AIR TEMPERATURE RANGE						
M. T	0°C TO 70°C	- 40°C TO 85°C					
TMS27C240-XXX	JL	JE					
TMS27PC240-XXX	FNL10	FNE					

These EPROMs and OTP PROMs operate from a single 5-V supply (in the read mode), and they are ideal for use in microprocessor-based systems. One other (13 V) supply is needed for programming. All programming signals are TTL level. For programming outside the system, existing EPROM programmers can be used.

operation

The eight modes of operation for the TMS27C240 and TMS27PC240 are listed in Table 2. The read mode requires a single 5-V supply. All inputs are TTL level except for V_{PP} during programming (13 V for SNAP! Pulse), and 12 V on A9 for the signature mode.

Table 2. Operation Modes

	TIW.	no. COM		FUNCTION	ITON CON	1.1	
	Ē	00 Y G	V _{PP}	VCC	A9	Α0	1/0
Read	VIL	100VIL	Vcc	Vcc	V.10 X	M.X	DQ0-DQ7 DQ8-DQ15
Output Disable	V _{IL}	VIH	Vcc	Vcc	X	O X	Hi-Z
Standby	VIH	X	Vcc	Vcc	X	X	Hi-Z
Programming	V _{IL}	VIH	V _{PP}	V _{CC} √	X	X	Data In
Verify	V _{IH}	VIL	V_{PP}	V _{CC}	X	COX	Data Out
Program Inhibit	VIH	VIH	V _{PP}	V _{CC}	X	X	Hi-Z
Signature Mode (Mfg)	VIL	V VIL	Vcc	Vcc	V _H ‡	V _I L	Manufacturer's Code 0097
Signature Mode (Device)	V _{IL}	VIL	Vcc	Vcc	V _H ‡	VIHCO	Device Code 0030

[†] X can be V_{IL} or V_{IH}.

read/output disable

When the outputs of two or more TMS27C240s or TMS27PC240s are connected in parallel on the same bus, the output of any particular device in the circuit can be read with no interference from the competing outputs of the other devices. To read the output of a single device, a low-level signal is applied to the \overline{E} and \overline{G} pins. All other devices in the circuit should have their outputs disabled by applying a high-level signal to one of these pins.



 $^{^{\}ddagger}$ V_H = 12 V ‡ 0.5 V.

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latchup immunity

Latchup immunity on the TMS27C240 and TMS27PC240 is a minimum of 250 mA on all inputs and outputs. This feature provides latchup immunity beyond any potential transients at the P.C. board level when the devices are interfaced to industry-standard TTL or MOS logic devices. Input-output layout approach controls latchup without compromising performance or packing density.

power down

Active I_{CC} supply current can be reduced from 50 mA to 1 mA by applying a high TTL input on \overline{E} and to 100 μ A by applying a high CMOS input on \overline{E} . In this mode all outputs are in the high-impedance state.

erasure (TMS27C240)

Before programming, the TMS27C240 is erased by exposing the chip through the transparent lid to a high intensity ultraviolet light (wavelength 2537 Å). The recommended minimum exposure dose (UV intensity \times exposure time) is 15-W·s/cm². A 12-mW/cm², filterless UV lamp erases the device in 21 minutes. The lamp should be located about 2.5 cm above the chip during erasure. After erasure, all bits are in the high state. It should be noted that normal ambient light contains the correct wavelength for erasure. Therefore, when using the TMS27C240, the window should be covered with an opaque label.

initializing (TMS27PC240)

The one-time programmable TMS27PC240 PROM is provided with all bits in the logic high state, then logic lows are programmed into the desired locations. Logic lows programmed into an OTP PROM cannot be erased.

SNAP! Pulse programming

The TMS27C240 and TMS27PC240 are programmed by using the SNAP! Pulse programming algorithm. The programming sequence is shown in the SNAP! Pulse programming flow chart, shown in Figure 1.

The initial setup is $V_{PP} = 13 \text{ V}$, $V_{CC} = 6.5 \text{ V}$, $\overline{E} = V_{IH}$, and $\overline{G} = V_{IH}$. Once the initial location is selected, the data is presented in parallel (eight bits) on pins DQ0 through DQ15. Once addresses and data are stable, the programming mode is achieved when \overline{E} is pulsed low (V_{IL}) with a pulse duration of $t_{W(PGM)}$. Every location is programmed only once before going to interactive mode.

In the interactive mode, the word is verified at $V_{PP} = 13$ V, $V_{CC} = 6.5$ V, $\overline{E} = V_{IH}$, and $\overline{G} = V_{IL}$. If the correct data is not read, the programming is performed by pulling \overline{E} low with a pulse duration of $t_{W(PGM)}$. This sequence of verification and programming is performed up to a maximum of 10 times. When the device is fully programmed, all bytes are verified with $V_{CC} = V_{PP} = 5$ V \pm 10%.

program inhibit

Programming can be inhibited by maintaining a high level input on the \overline{E} and \overline{G} pins.

program verify

Programmed bits can be verified with $V_{PP} = 13 \text{ V}$ when $\overline{G} = V_{IL}$ and $\overline{E} = V_{IH}$.



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signature mode

The signature mode provides access to a binary code identifying the manufacturer and type. This mode is activated when A9 (pin 31 for the J package) is forced to 12 V. Two identifier bytes are accessed by toggling A0. DQ0-DQ7 contain the valid codes. All other addresses must be held low. The signature code for these devices is 9730. A0 low selects the manufacturer's code 97 (Hex), and A0 high selects the device code 30 (Hex), as shown in Table 3.

Table 3. Signature Mode

7. 201.100	0_{M}	1		M. Inc	COPI	NS		WWIE	.To	CO_{L}
IDENTIFIERT	Α0	DQ7	DQ6	DQ5	DQ4	DQ3	DQ2	DQ1	DQ0	HEX
MANUFACTURER CODE	V _{IL}	1	0	0 10	11	0	1	1	100	97
DEVICE CODE	VIH	<<10	0	1	~1 C	0	N O	0	0	30

WWW.100Y.COM.TW $^{\dagger}\overline{E} = \overline{G} = V_{IL}$, A9 = V_H, A1 – A8 = V_{IL}, A10 – A17 = V_{IL}, V_{PP} = V_{CC}, \overline{PGM} = V_{IH} or V_{IL}. WWW.100Y.COM.

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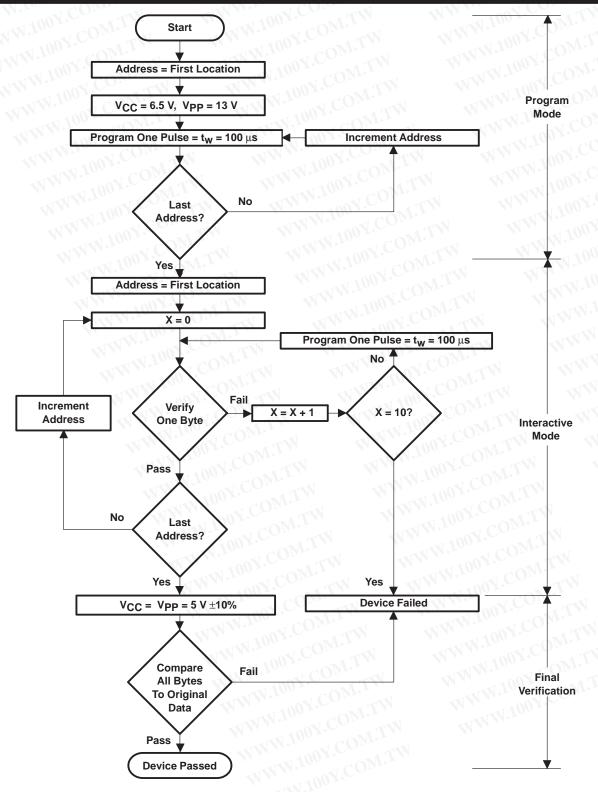


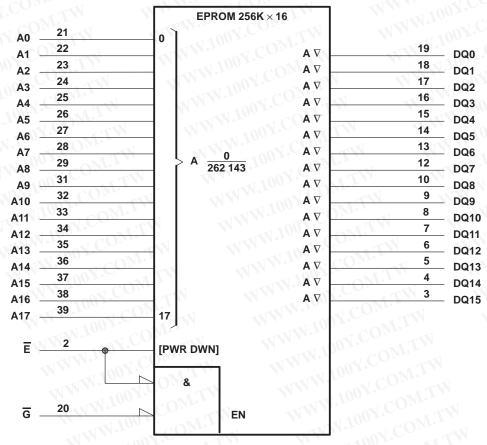
Figure 1. SNAP! Pulse Programming Flow Chart



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logic symbol†



[†] These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers are for the J package.

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage range, V_{CC} (see Note 1) -0.6 V to 7 V Supply voltage range, V_{PP} -0.6 V to 13 V Input voltage range (see Note 1): All inputs except A9 -0.6 V to V_{CC} + 1 V A9 -0.6 V to V_{CC} + 1 V Output voltage range (see Note 1) -0.6 V to V_{CC} + 1 V

recommended operating conditions

	W 100 Y.	OM.TW	W. 1001.	MIN	NOM	MAX	UNIT
\/	Supply voltage	Read mode	4.5	5	5.5	1100	
VCC	Supply voltage	SNAP! Pulse	6.25	6.5	6.75	1V	
\/	Cumply yeltogo	Read mode	TANN. Inc	V _{CC} -0.6	×N	V _{CC} +0.6	W.Ye
VPP Supply voltage		SNAP! Pulse	e programming algorithm	12.75	13	13.25	v.1
V _{IH} High-level dc input voltage	Y.Co. TY	TTL WWW.10	2	IM	V _{CC} +0.5	V	
		CMOS	V _{CC} - 0.2	WT	V _{CC} +0.5	V	
\/	Low level de input veltage	COM	TTL	- 0.5	1.	0.8	
VIL	Low-level dc input voltage	00λ .	CMOS	- 0.5	M.r.	0.2	V
TA	Operating free-air temperature	100 X CON	'27C240JL '27PC240 FNL	V.100 Y.0C	M^{T}	70	°C
ТД	Operating free-air temperature	N.100 T.CO.	'27PC240FNE '27C240JE	- 40	OM	85	°C

NOTE 2: V_{CC} must be applied before or at the same time as V_{PP} and removed after or at the same time as V_{PP}. The device must not be inserted into or removed from the board when V_{PP} or V_{CC} is applied.



[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: All voltage values are with respect to GND.

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electrical characteristics over recommended ranges of supply voltage and operating free-air temperature

- 11	PARAMETER	TEST CONDITIONS	MIN MAX	UNIT
V	This level de suite Chale	I _{OH} = - 400 μA	2.4	V
VOH	High-level dc output voltage	I _{OH} = - 20 μA	V _{CC} – 0.1	V
V	Low level de output veltage	I _{OL} = 2.1 mA	0.4	V
VOL	Low-level dc output voltage	I _{OL} = 20 μA	0.1	WT
II	Input current (leakage)	V _I = 0 V to 5.5 V	11 (±1)	μА
ΙO	Output current (leakage)	$V_O = 0 \text{ V to } V_{CC}$	±1,	μА
IPP1	Vpp supply current	Vpp = V _{CC} = 5.5 V	10	μА
IPP2	Vpp supply current (during program pulse)	Vpp = 13 V	50	mA
laa.	VCC quanty quarent (aton dis.)	$V_{CC} = 5.5 \text{ V}, \qquad \overline{E} = V_{IH}$	WWW.I	mA
ICC1	VCC supply current (standby)	$V_{CC} = 5.5 \text{ V}, \qquad \overline{E} = V_{CC}$	100	μА
I _{CC2}	V _{CC} supply current (active)	V _{CC} = 5.5 V, $\overline{E} = V_{ L}$, t _{cycle} = minimum cycle time, outputs open	50	mA

capacitance over recommended ranges voltage and operating free-air of supply temperature, f = 1 MHz[†]

	PARAMETER	TEST CONDITIONS	MIN	TYP‡	MAX	UNIT
Ci	Input capacitance	V _I = 0 V		4	8	pF
Co	Output capacitance	V _O = 0 V	TW	8	12	pF

[†] Capacitance measurements are made on a sample basis only.

switching characteristics over recommended ranges of operating conditions (see Notes 3 and 4)

	PARAMETER	TEST CONDITIONS			V		'27C240-15 '27 PC240-15		UNIT
		MIN MAX		MIN MAX		MIN MAX		M	
t _{a(A)}	Access time from address	Y.Co. TW	W	100	1001	120	TW	150	ns
ta(E)	Access time from chip enable	C _L = 100 pF,	17	100	. 001	120	WT	150	ns
t _{en(G)}	Output enable time from G	1 Series 74		50	'Ja	50	Mr.	50	ns
^t dis	Output disable time from \overline{G} or \overline{E} , whichever occurs first $\overline{\dagger}$	TTL load, Input $t_r \le 20$ ns, Input $t_f \le 20$ ns	0	50	0	50	0	50	ns
t _V (A)	Output data valid time after change of address, E, or G, whichever occurs first§	1 20 113	0	W	0	00Y.C	0	TW	ns

[§] Value calculated from 0.5 V delta to measured level.

NOTES: 3. For all switching characteristics, the input pulse levels are 0.4 V to 2.4 V. Timing measurements are made at 2 V for logic high and WWW.100Y.COM. 0.8 V for logic low (see Figure 2).

4. Common test conditions apply for t_{dis} except during programming.



[‡] Typical values are at T_A = 25°C and nominal voltages.

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switching characteristics for programming: $V_{CC} = 6.5 \text{ V}$ and $V_{PP} = 13 \text{ V}$ (SNAP! Pulse), $T_A = 25^{\circ}\text{C}$ (see Note 3)

	MAN TOO COMP.	PARAMETER	MIN	MAX	UNIT
tdis(G)	Output disable time from G	CONT.	0	100	ns
ten(G)	Output enable time from G	M 1001.	1.10	150	ns

NOTE 3: For all switching characteristics the input pulse levels are 0.4 V to 2.4 V. Timing measurements are made at 2 V for logic high and WWW.100Y.CC ML100Y.COM.TW 0.8 V for logic low. (See Figure 2)

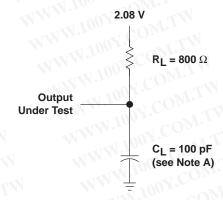
timing requirements for programming

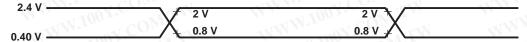
	WWW.Cov.Cov	WW LOOK TW	MIN	NOM MAX	UNIT
tw(PGM)	Pulse duration, program	SNAP! Pulse programming algorithm	95	100 105	μs
t _{su(A)}	Setup time, address	M. Too COM.	2	TWW.IC	μs
t _{su(E)}	Setup time, E	W" 1001.	2		μs
^t su(G)	Setup time, G	WWW.100Y.CO.IT	2	MAA	μs
t _{su(D)}	Setup time, data	N MAN. TO OA. COM.	2	MAIN	μs
t _{su(VPP)}	Setup time, Vpp	COM.	2		μs
t _{su(VCC)}	Setup time, V _{CC}	M 1001.	2	N. T.	μs
th(A)	Hold time, address	TW WWW. 100X.CO	0	MAN	μs
^t h(D)	Hold time, data	NWW. COL	2	W	μs

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PARAMETER MEASUREMENT INFORMATION





NOTES: A. C_L includes probe and fixture capacitance.

B. The ac testing inputs are driven at 2.4 V for logic high and 0.4 V for logic low. Timing measurements are made at 2 V for logic high and 0.8 V for logic low for both inputs and outputs.

Figure 2. The ac Testing Output Load Circuit and Waveform

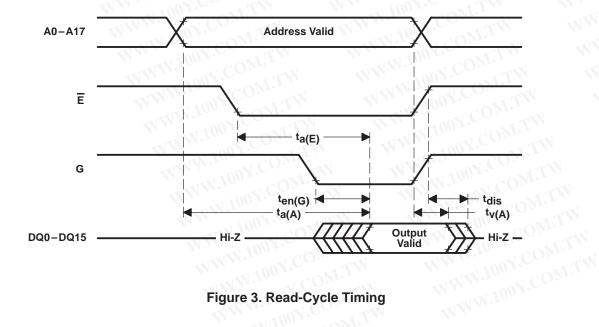
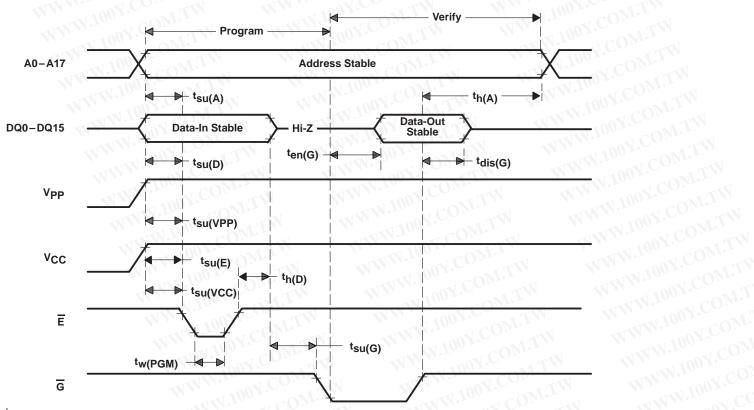


Figure 3. Read-Cycle Timing

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PARAMETER MEASUREMENT INFORMATION



† 13-V VPP and 6.5-V VCC for SNAP! Pulse programming

Figure 4. Programming-Cycle Timing (SNAP! Pulse Programming)

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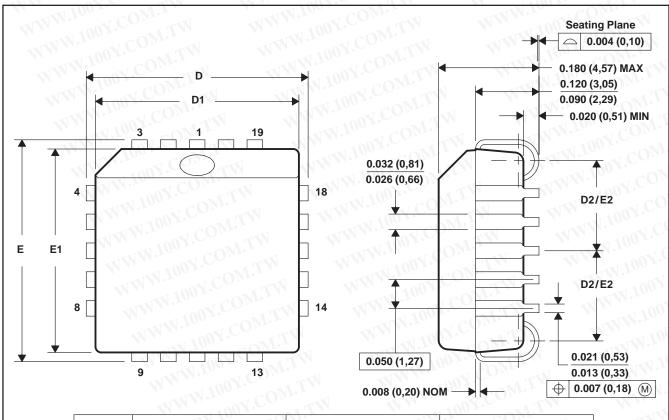
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FN (S-PQCC-J**)

20 PIN SHOWN

PLASTIC J-LEADED CHIP CARRIER



NO. OF	D	E 100Y.CO	D1	/E1	D2/E2		
PINS **	MIN	MAX	MIN	MAX	MIN	MAX	
20	0.385 (9,78)	0.395 (10,03)	0.350 (8,89)	0.356 (9,04)	0.141 (3,58)	0.169 (4,29)	
28	0.485 (12,32)	0.495 (12,57)	0.450 (11,43)	0.456 (11,58)	0.191 (4,85)	0.219 (5,56)	
44	0.685 (17,40)	0.695 (17,65)	0.650 (16,51)	0.656 (16,66)	0.291 (7,39)	0.319 (8,10)	
52	0.785 (19,94)	0.795 (20,19)	0.750 (19,05)	0.756 (19,20)	0.341 (8,66)	0.369 (9,37)	
68	0.985 (25,02)	0.995 (25,27)	0.950 (24,13)	0.958 (24,33)	0.441 (11,20)	0.469 (11,91)	
84	1.185 (30,10)	1.195 (30,35)	1.150 (29,21)	1.158 (29,41)	0.541 (13,74)	0.569 (14,45)	

4040005/B 03/95

NOTES: A. All linear dimensions are in inches (millimeters).

- WWW.100Y.COM.TW B. This drawing is subject to change without notice. WWW.100Y.COM.TW
- C. Falls within JEDEC MS-018

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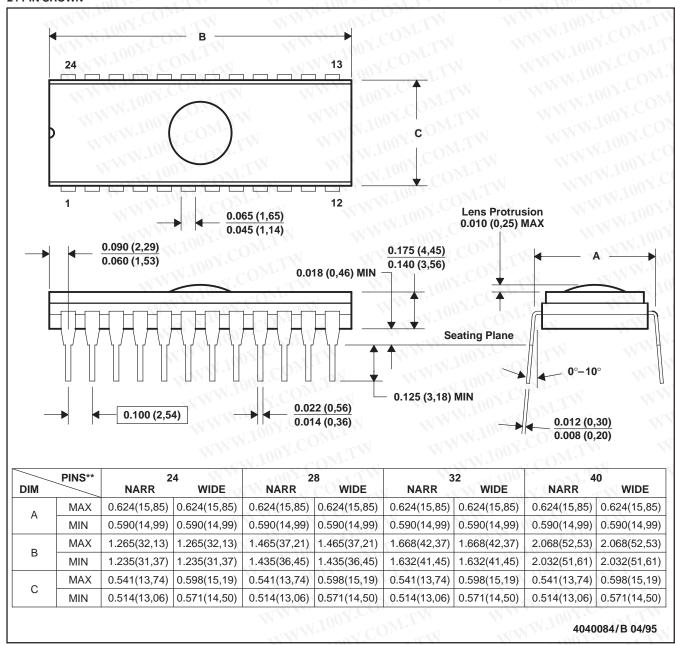
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J (R-CDIP-T**)

CERAMIC SIDE-BRAZE DUAL-IN-LINE PACKAGE

24 PIN SHOWN



NOTES: A. All linear dimensions are in inches (millimeters).

- B. This drawing is subject to change without notice.
- C. This package can be hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.



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